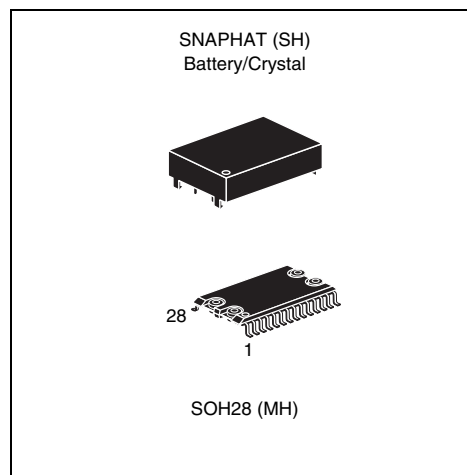
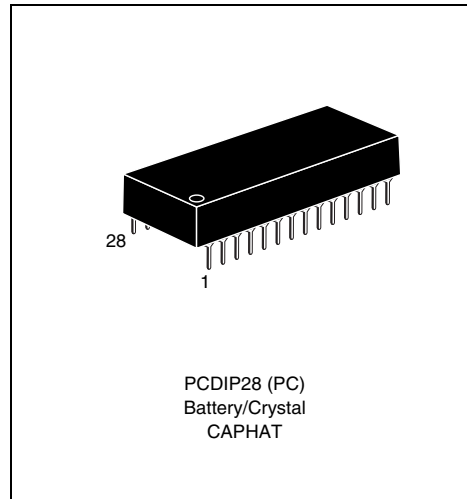


## 5V, 256 Kbit (32 Kb x 8) TIMEKEEPER® SRAM

### Features

- Integrated, ultra low power SRAM, real time clock, power-fail control circuit and battery
- BYTEWIDE™ RAM-like clock access
- BCD coded year, month, day, date, hours, minutes, and seconds
- Frequency test output for real time clock
- Automatic power-fail chip deselect and WRITE protection
- WRITE protect voltages
  - ( $V_{PFD}$  = Power-fail Deselect Voltage):
    - M48T35:  $V_{CC} = 4.75$  to  $5.5V$
    - $4.5V \leq V_{PFD} \leq 4.75V$
    - M48T35Y:  $V_{CC} = 4.5$  to  $5.5V$
    - $4.2V \leq V_{PFD} \leq 4.5V$
- Self-contained battery and crystal in the CAPHAT™ DIP package
- SOIC package provides direct connection for a SNAPHAT® housing containing the battery and crystal
- SNAPHAT® housing (battery and crystal) is replaceable
- Pin and function compatible with JEDEC standard 32 Kb x 8 SRAMs
- RoHS compliant
  - Lead-free second level interconnect



# Contents

<b>1</b>	<b>Summary description .....</b>	<b>5</b>
<b>2</b>	<b>Operation modes .....</b>	<b>8</b>
2.1	Read mode .....	8
2.2	Write mode .....	9
2.3	Data retention mode .....	11
<b>3</b>	<b>Clock operations .....</b>	<b>12</b>
3.1	Reading the clock .....	12
3.2	Setting the clock .....	12
3.3	Stopping and starting the oscillator .....	12
3.4	Calibrating the clock .....	13
3.5	Century bit .....	14
3.6	V <sub>CC</sub> noise and negative going transients .....	15
<b>4</b>	<b>Maximum rating .....</b>	<b>17</b>
<b>5</b>	<b>DC and AC parameters .....</b>	<b>18</b>
<b>6</b>	<b>Package mechanical information .....</b>	<b>21</b>
<b>7</b>	<b>Part numbering .....</b>	<b>26</b>
<b>8</b>	<b>Revision history .....</b>	<b>28</b>

## List of tables

Table 1.	Signal names . . . . .	6
Table 2.	Operating modes . . . . .	8
Table 3.	Read mode AC characteristics . . . . .	9
Table 4.	Write mode AC characteristics . . . . .	10
Table 5.	Register map . . . . .	13
Table 6.	Absolute maximum ratings . . . . .	17
Table 7.	Operating and AC measurement conditions . . . . .	18
Table 8.	Capacitance . . . . .	18
Table 9.	DC characteristics . . . . .	19
Table 10.	Power down/up AC characteristics . . . . .	20
Table 11.	Power down/up trip points DC characteristics . . . . .	20
Table 12.	PCDIP28 – 28-pin plastic DIP, battery CAPHAT, package mechanical data . . . . .	21
Table 13.	SOH28 – 28-lead plastic SO, 4-socket battery SNAPHAT, package mechanical data . . . . .	22
Table 14.	SH – 4-pin SNAPHAT housing for 48mAh battery & crystal, package mechanical data . . . . .	23
Table 15.	SH – 4-pin SNAPHAT housing for 120mAh battery & crystal, package mechanical data . . . . .	24
Table 16.	PMDIP28 – 28-pin plastic DIP, hybrid, package mechanical data . . . . .	25
Table 17.	Ordering information scheme . . . . .	26
Table 18.	SNAPHAT battery table . . . . .	27
Table 19.	Document revision history . . . . .	28

## List of figures

Figure 1.	Logic diagram . . . . .	5
Figure 2.	DIP connections . . . . .	6
Figure 3.	SOIC connections . . . . .	6
Figure 4.	Block diagram . . . . .	7
Figure 5.	Read mode AC waveforms . . . . .	9
Figure 6.	Write enable controlled, write AC waveform . . . . .	10
Figure 7.	Chip enable controlled, write AC waveforms . . . . .	10
Figure 8.	Crystal accuracy across temperature . . . . .	15
Figure 9.	Clock calibration . . . . .	15
Figure 10.	Supply voltage protection . . . . .	16
Figure 11.	AC measurement load circuit . . . . .	18
Figure 12.	Power down/up mode AC waveforms . . . . .	19
Figure 13.	PCDIP28 – 28-pin plastic DIP, battery CAPHAT, package outline . . . . .	21
Figure 14.	SOH28 – 28-lead plastic small outline, 4-socket battery SNAPHAT, package outline . . . . .	22
Figure 15.	SH – 4-pin SNAPHAT housing for 48mAh battery & crystal, package outline . . . . .	23
Figure 16.	SH – 4-pin SNAPHAT housing for 120mAh battery & crystal, package outline . . . . .	24
Figure 17.	PMDIP28 – 28-pin plastic DIP, hybrid, package outline . . . . .	25

# 1 Summary description

The M48T35/Y TIMEKEEPER® RAM is a 32Kb x 8 non-volatile static RAM and real time clock. The monolithic chip is available in two special packages to provide a highly integrated battery backed-up memory and real time clock solution.

The M48T35/Y is a non-volatile pin and function equivalent to any JEDEC standard 32Kb x 8 SRAM. It also easily fits into many ROM, EPROM, and EEPROM sockets, providing the non-volatility of PROMs without any requirement for special WRITE timing or limitations on the number of WRITES that can be performed.

The 28-pin, 600mil DIP CAPHAT houses the M48T35/Y silicon with a quartz crystal and a long life lithium button cell in a single package.

The 28-pin, 330mil SOIC provides sockets with gold plated contacts at both ends for direct connection to a separate SNAPHAT® housing containing the battery and crystal. The unique design allows the SNAPHAT battery package to be mounted on top of the SOIC package after the completion of the surface mount process. Insertion of the SNAPHAT housing after reflow prevents potential battery and crystal damage due to the high temperatures required for device surface-mounting. The SNAPHAT housing is keyed to prevent reverse insertion. The SOIC and battery/crystal packages are shipped separately in plastic anti-static tubes or in Tape & Reel form.

For the 28-lead SOIC, the battery/crystal package (e.g., SNAPHAT) part number is "M4T28-BR12SH" (see [Table 18 on page 27](#)).

**Figure 1. Logic diagram**

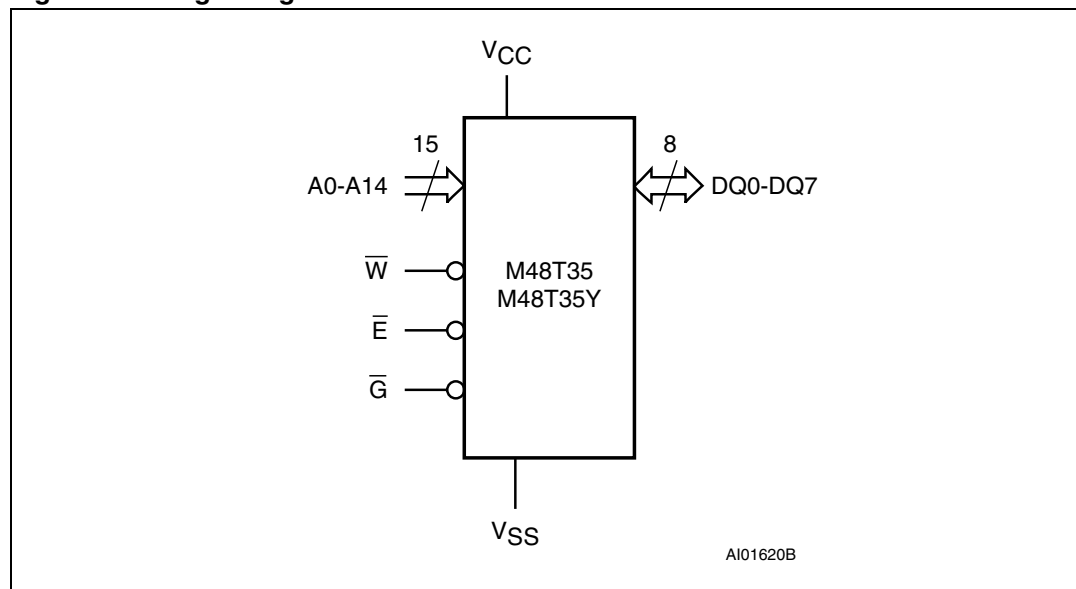


Table 1. Signal names

A0-A14	Address inputs
DQ0-DQ7	Data inputs / outputs
E	Chip enable
G	Output enable
W	WRITE Enable
V <sub>CC</sub>	Supply voltage
V <sub>SS</sub>	Ground

Figure 2. DIP connections

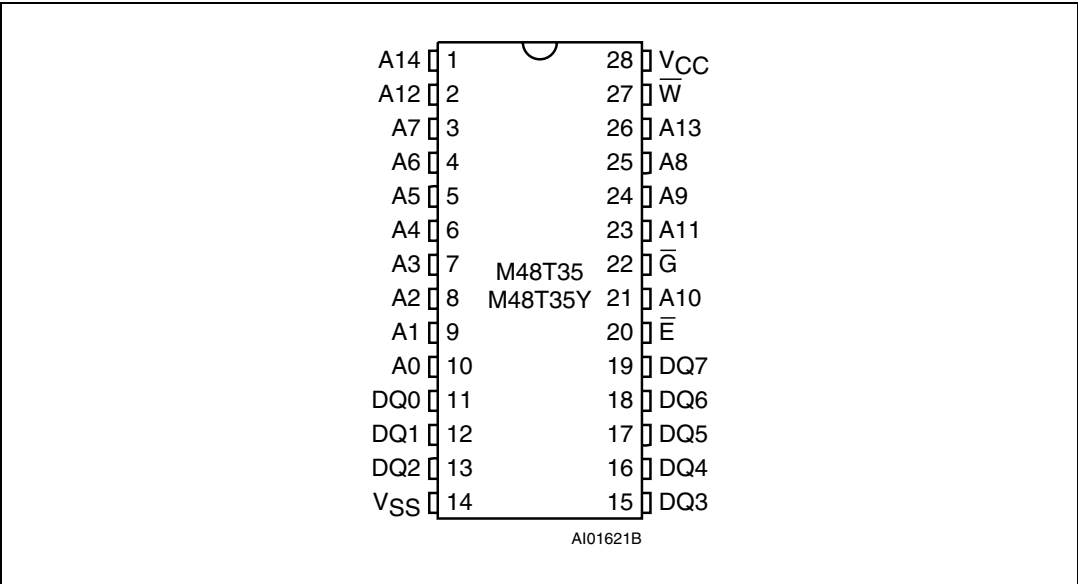


Figure 3. SOIC connections

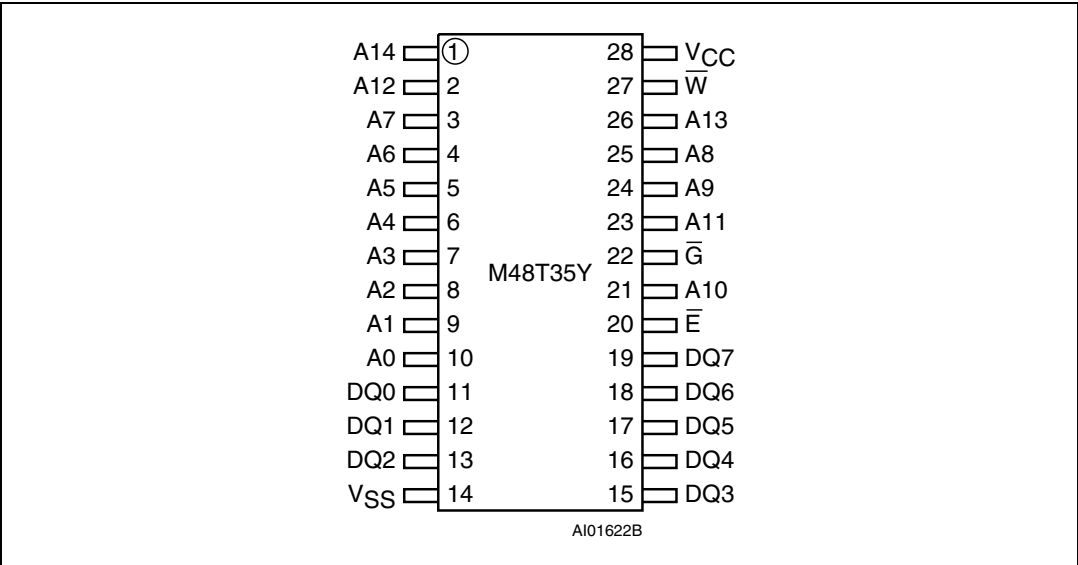
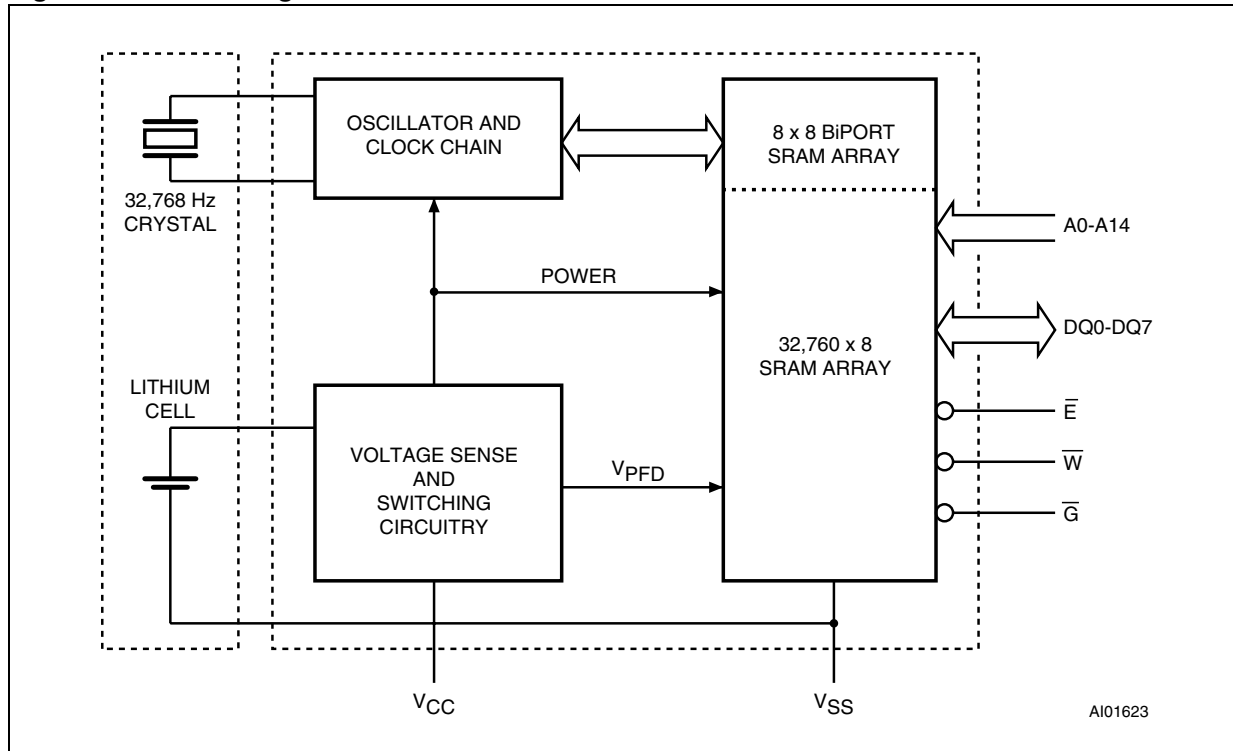


Figure 4. Block diagram



## 2 Operation modes

As [Figure 4 on page 7](#) shows, the static memory array and the quartz controlled clock oscillator of the M48T35/Y are integrated on one silicon chip. The two circuits are interconnected at the upper eight memory locations to provide user accessible BYTEWIDE clock information in the bytes with addresses 7FF8h-7FFFh.

The clock locations contain the year, month, date, day, hour, minute, and second in 24 hour BCD format. Corrections for 28, 29 (leap year - valid until 2100), 30, and 31 day months are made automatically. Byte 7FF8h is the clock control register. This byte controls user access to the clock information and also stores the clock calibration setting.

The eight clock bytes are not the actual clock counters themselves; they are memory locations consisting of BiPORT™ READ/WRITE memory cells. The M48T35/Y includes a clock control circuit which updates the clock bytes with current information once per second. The information can be accessed by the user in the same manner as any other location in the static memory array.

The M48T35/Y also has its own Power-fail Detect circuit. The control circuitry constantly monitors the single 5V supply for an out of tolerance condition. When  $V_{CC}$  is out of tolerance, the circuit write protects the SRAM, providing a high degree of data security in the midst of unpredictable system operation brought on by low  $V_{CC}$ . As  $V_{CC}$  falls below the Battery Back-up Switchover Voltage ( $V_{SO}$ ), the control circuitry connects the battery which maintains data and clock operation until valid power returns.

**Table 2. Operating modes**

Mode	$V_{CC}$	$\bar{E}$	$\bar{G}$	$\bar{W}$	DQ0-DQ7	Power
Deselect	4.75 to 5.5V or 4.5 to 5.5V	$V_{IH}$	X	X	High Z	Standby
WRITE		$V_{IL}$	X	$V_{IL}$	$D_{IN}$	Active
READ		$V_{IL}$	$V_{IL}$	$V_{IH}$	$D_{OUT}$	Active
READ		$V_{IL}$	$V_{IH}$	$V_{IH}$	High Z	Active
Deselect	$V_{SO}$ to $V_{PFD}$ (min) <sup>(1)</sup>	X	X	X	High Z	CMOS Standby
Deselect	$\leq V_{SO}$ <sup>(1)</sup>	X	X	X	High Z	Battery Back-up Mode

1. See [Table 11 on page 20](#) for details.

Note:  $X = V_{IH}$  or  $V_{IL}$ ;  $V_{SO}$  = Battery Back-up Switchover Voltage.

### 2.1 Read mode

The M48T35/Y is in the READ Mode whenever  $\bar{W}$  (WRITE Enable) is high and  $\bar{E}$  (Chip Enable) is low. The unique address specified by the 15 Address Inputs defines which one of the 32,768 bytes of data is to be accessed. Valid data will be available at the Data I/O pins within Address Access time ( $t_{AVQV}$ ) after the last address input signal is stable, providing that the  $\bar{E}$  and  $\bar{G}$  access times are also satisfied.

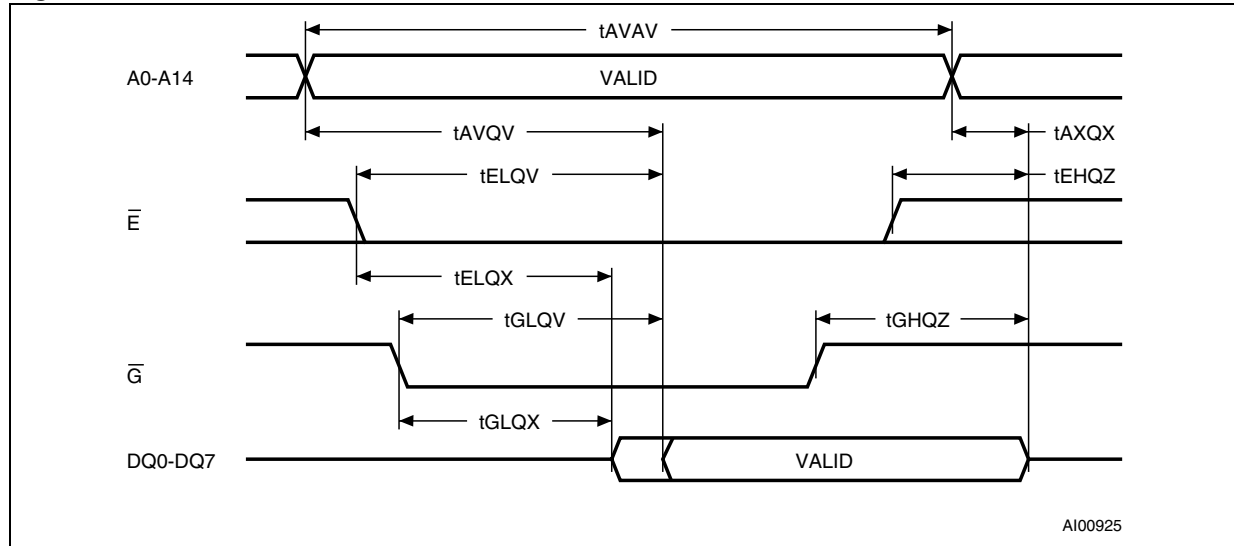
If the  $\bar{E}$  and  $\bar{G}$  access times are not met, valid data will be available after the latter of the Chip Enable Access time ( $t_{ELQV}$ ) or Output Enable Access time ( $t_{GLQV}$ ).

The state of the eight three-state Data I/O signals is controlled by  $\bar{E}$  and  $\bar{G}$ . If the outputs are activated before  $t_{AVQV}$ , the data lines will be driven to an indeterminate state until  $t_{AVQV}$ .



If the Address Inputs are changed while  $\overline{E}$  and  $\overline{G}$  remain active, output data will remain valid for Output Data Hold time ( $t_{AXQX}$ ) but will go indeterminate until the next Address Access.

**Figure 5. Read mode AC waveforms**



Note: WRITE Enable ( $\overline{W}$ ) = High.

**Table 3. Read mode AC characteristics**

Symbol	Parameter <sup>(1)</sup>	M48T35/Y		Unit
		Min	Max	
$t_{AVAV}$	READ Cycle Time	70		ns
$t_{AVQV}$	Address Valid to Output Valid		70	ns
$t_{ELQV}$	Chip Enable Low to Output Valid		70	ns
$t_{GLQV}$	Output Enable Low to Output Valid		35	ns
$t_{ELQX}^{(2)}$	Chip Enable Low to Output Transition	5		ns
$t_{GLQX}^{(2)}$	Output Enable Low to Output Transition	5		ns
$t_{EHQZ}^{(2)}$	Chip Enable High to Output Hi-Z		25	ns
$t_{GHQZ}^{(2)}$	Output Enable High to Output Hi-Z		25	ns
$t_{AXQX}$	Address Transition to Output Transition	10		ns

1. Valid for Ambient Operating Temperature:  $T_A = 0$  to  $70$  or  $-40$  to  $85^\circ\text{C}$ ;  $V_{CC} = 4.75$  to  $5.5\text{V}$  or  $4.5$  to  $5.5\text{V}$  (except where noted).

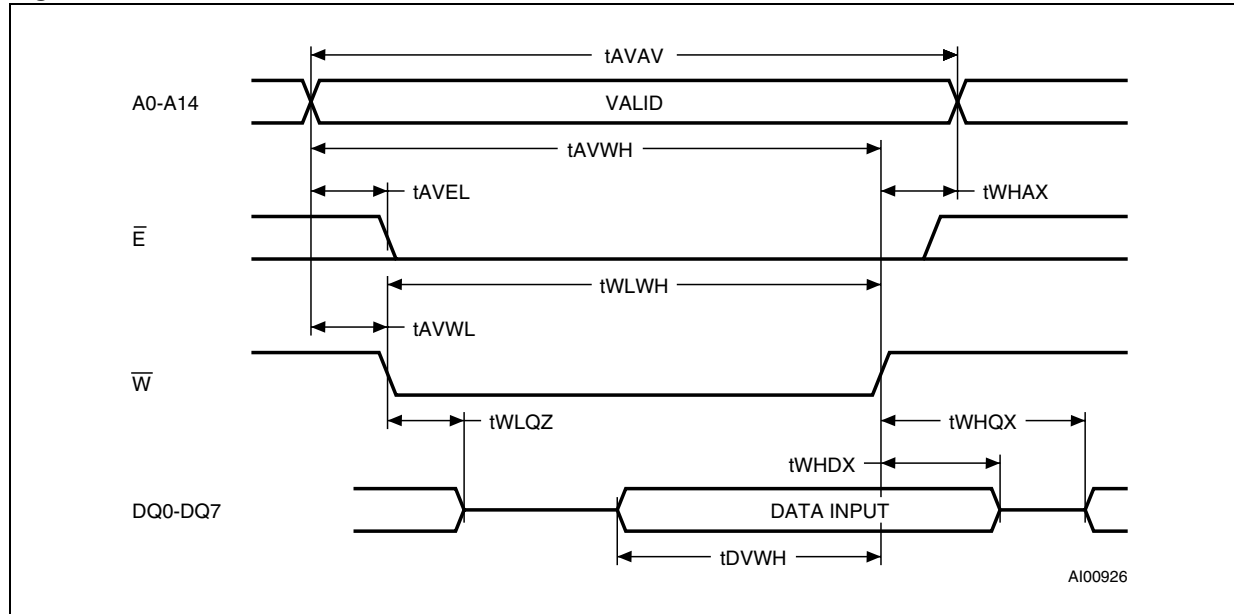
2.  $C_L = 5\text{pF}$ .

## 2.2 Write mode

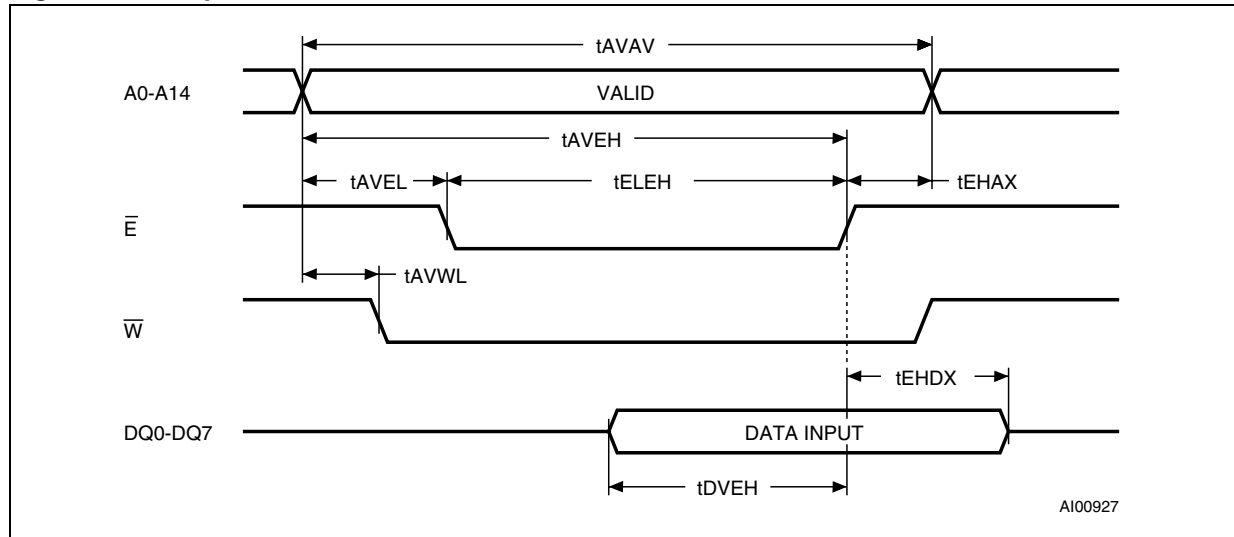
The M48T35/Y is in the WRITE Mode whenever  $\overline{W}$  and  $\overline{E}$  are low. The start of a WRITE is referenced from the latter occurring falling edge of  $\overline{W}$  or  $\overline{E}$ . A WRITE is terminated by the earlier rising edge of  $\overline{W}$  or  $\overline{E}$ . The addresses must be held valid throughout the cycle.  $\overline{E}$  or  $\overline{W}$  must return high for a minimum of  $t_{EHAX}$  from Chip Enable or  $t_{WHAX}$  from WRITE Enable prior to the initiation of another READ or WRITE Cycle. Data-in must be valid  $t_{DVWH}$  prior to the end of WRITE and remain valid for  $t_{WHDx}$  afterward.  $\overline{G}$  should be kept high during

WRITE Cycles to avoid bus contention; although, if the output bus has been activated by a low on  $\bar{E}$  and  $\bar{G}$ , a low on  $\bar{W}$  will disable the outputs  $t_{WLQZ}$  after  $\bar{W}$  falls.

**Figure 6. Write enable controlled, write AC waveform**



**Figure 7. Chip enable controlled, write AC waveforms**



**Table 4. Write mode AC characteristics**

Symbol	Parameter <sup>(1)</sup>	M48T35/Y		Unit
		Min	Max	
$t_{AVAV}$	WRITE Cycle Time	70		ns
$t_{AVWL}$	Address Valid to WRITE Enable Low	0		ns
$t_{AVEL}$	Address Valid to Chip Enable Low	0		ns

**Table 4. Write mode AC characteristics (continued)**

Symbol	Parameter <sup>(1)</sup>	M48T35/Y		Unit
		Min	Max	
$t_{WLWH}$	WRITE Enable Pulse Width	50		ns
$t_{ELEH}$	Chip Enable Low to Chip Enable High	55		ns
$t_{WHAX}$	WRITE Enable High to Address Transition	0		ns
$t_{EHAX}$	Chip Enable High to Address Transition	0		ns
$t_{DVWH}$	Input Valid to WRITE Enable High	30		ns
$t_{DVEH}$	Input Valid to Chip Enable High	30		ns
$t_{WHDX}$	WRITE Enable High to Input Transition	5		ns
$t_{EHDX}$	Chip Enable High to Input Transition	5		ns
$t_{WLQZ}^{(2)(3)}$	WRITE Enable Low to Output Hi-Z		25	ns
$t_{AVWH}$	Address Valid to WRITE Enable High	60		ns
$t_{AVEH}$	Address Valid to Chip Enable High	60		ns
$t_{WHQX}^{(2)(3)}$	WRITE Enable High to Output Transition	5		ns

1. Valid for Ambient Operating Temperature:  $T_A = 0$  to  $70$  or  $-40$  to  $85^\circ\text{C}$ ;  $V_{CC} = 4.75$  to  $5.5\text{V}$  or  $4.5$  to  $5.5\text{V}$  (except where noted).

2.  $C_L = 5\text{pF}$ .

3. If  $\overline{E}$  goes low simultaneously with  $\overline{W}$  going low, the outputs remain in the high impedance state.

## 2.3 Data retention mode

With valid  $V_{CC}$  applied, the M48T35/Y operates as a conventional BYTEWIDE static RAM. Should the supply voltage decay, the RAM will automatically power-fail deselect, write protecting itself when  $V_{CC}$  falls within the  $V_{PFD}(\text{max})$ ,  $V_{PFD}(\text{min})$  window. All outputs become high impedance, and all inputs are treated as "Don't care" (see [Figure 12 on page 19](#), [Table 10](#), and [Table 11 on page 20](#)).

**Note:** *A power failure during a WRITE cycle may corrupt data at the currently addressed location, but does not jeopardize the rest of the RAM's content. At voltages below  $V_{PFD}(\text{min})$ , the user can be assured the memory will be in a write protected state, provided the  $V_{CC}$  fall time is not less than  $t_F$ . The M48T35/Y may respond to transient noise spikes on  $V_{CC}$  that reach into the deselect window during the time the device is sampling  $V_{CC}$ . Therefore, decoupling of the power supply lines is recommended.*

When  $V_{CC}$  drops below  $V_{SO}$ , the control circuit switches power to the internal battery which preserves data and powers the clock. The internal button cell will maintain data in the M48T35/Y for an accumulated period of at least 7 years when  $V_{CC}$  is less than  $V_{SO}$ . As system power returns and  $V_{CC}$  rises above  $V_{SO}$ , the battery is disconnected, and the power supply is switched to external  $V_{CC}$ . Write protection continues until  $V_{CC}$  reaches  $V_{PFD}(\text{min})$  plus  $t_{rec}(\text{min})$ .  $\overline{E}$  should be kept high as  $V_{CC}$  rises past  $V_{PFD}(\text{min})$  to prevent inadvertent WRITE Cycles prior to processor stabilization. Normal RAM operation can resume  $t_{rec}$  after  $V_{CC}$  exceeds  $V_{PFD}(\text{max})$ .

For more information on Battery Storage Life refer to the Application Note AN1012.

## 3 Clock operations

### 3.1 Reading the clock

Updates to the TIMEKEEPER® registers (see [Table 5](#)) should be halted before clock data is read to prevent reading data in transition. The BiPORT™ TIMEKEEPER cells in the RAM array are only data registers and not the actual clock counters, so updating the registers can be halted without disturbing the clock itself.

Updating is halted when a '1' is written to the READ Bit, D6 in the Control Register 7FF8h. As long as a '1' remains in that position, updating is halted.

After a halt is issued, the registers reflect the count; that is, the day, date, and the time that were current at the moment the halt command was issued.

All of the TIMEKEEPER registers are updated simultaneously. A halt will not interrupt an update in progress. Updating is within a second after the bit is reset to a '0.'

### 3.2 Setting the clock

Bit D7 of the Control Register 7FF8h is the WRITE Bit. Setting the WRITE Bit to a '1,' like the READ Bit, halts updates to the TIMEKEEPER® registers. The user can then load them with the correct day, date, and time data in 24 hour BCD format (see [Table 5](#)). Resetting the WRITE Bit to a '0' then transfers the values of all time registers 7FF9h-7FFFh to the actual TIMEKEEPER counters and allows normal operation to resume. The FT Bit and the bits marked as '0' in [Table 5](#) must be written to '0' to allow for normal TIMEKEEPER and RAM operation. After the WRITE Bit is reset, the next clock update will occur within one second.

See the Application Note AN923, "TIMEKEEPER® Rolling Into the 21<sup>st</sup> Century" for information on Century Rollover.

### 3.3 Stopping and starting the oscillator

The oscillator may be stopped at any time. If the device is going to spend a significant amount of time on the shelf, the oscillator can be turned off to minimize current drain on the battery. The STOP Bit is the MSB of the seconds register. Setting it to a '1' stops the oscillator. The M48T35/Y is shipped from STMicroelectronics with the STOP Bit set to a '1.' When reset to a '0,' the M48T35/Y oscillator starts within 1 second.

**Table 5. Register map**

Address	Data								Function/Range BCD Format	
	D7	D6	D5	D4	D3	D2	D1	D0		
7FFFh	10 Years				Year				Year	00-99
7FFEh	0	0	0	10 M.	Month				Month	01-12
7FFDh	0	0	10 Date		Date				Date	01-31
7FFCh	0	FT	CEB	CB	0	Day			Century/ Day	00-01/01-07
7FFBh	0	0	10 Hours		Hours				Hours	00-23
7FFAh	0	10 Minutes			Minutes				Minutes	00-59
7FF9h	ST	10 Seconds			Seconds				Seconds	00-59
7FF8h	W	R	S	Calibration					Control	

Keys:

S = SIGN Bit

FT = FREQUENCY TEST Bit (Must be set to '0' upon power for normal operation)

R = READ Bit

W = WRITE Bit

ST = STOP Bit

0 = Must be set to '0'

CEB = Century Enable Bit

CB = Century Bit

**Note:** When CEB is set to '1,' CB will toggle from '0' to '1' or from '1' to '0' at the turn of the century (dependent upon the initial value set).

When CEB is set to '0,' CB will not toggle. The WRITE Bit does not need to be set to write to CEB.

### 3.4 Calibrating the clock

The M48T35/Y is driven by a quartz-controlled oscillator with a nominal frequency of 32,768 Hz. The devices are tested not to exceed 35 ppm (parts per million) oscillator frequency error at 25°C, which equates to about  $\pm 1.53$  minutes per month. With the calibration bits properly set, the accuracy of each M48T35/Y improves to better than  $\pm 1/-2$  ppm at 25°C.

The oscillation rate of any crystal changes with temperature (see [Figure 8 on page 15](#)). Most clock chips compensate for crystal frequency and temperature shift error with cumbersome "trim" capacitors. The M48T35/Y design, however, employs periodic counter correction. The calibration circuit adds or subtracts counts from the oscillator divider circuit at the divide by 256 stage, as shown in [Figure 9 on page 15](#). The number of times pulses are blanked (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in the Control Register. Adding counts speeds the clock up, subtracting counts slows the clock down.

The Calibration Byte occupies the five lower order bits (D4-D0) in the Control Register 7FF8h. These bits can be set to represent any value between 0 and 31 in binary form. Bit D5 is the Sign Bit; '1' indicates positive calibration, '0' indicates negative calibration. Calibration occurs within a 64 minute cycle. The first 62 minutes in the cycle may, once per

minute, have one second either shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first 2 minutes in the 64 minute cycle will be modified; if a binary 6 is loaded, the first 12 will be affected, and so on.

Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is +4.068 or -2.034 ppm of adjustment per calibration step in the calibration register. Assuming that the oscillator is in fact running at exactly 32,768 Hz, each of the 31 increments in the Calibration Byte would represent +10.7 or -5.35 seconds per month which corresponds to a total range of +5.5 or -2.75 minutes per month.

Two methods are available for ascertaining how much calibration a given M48T35/Y may require. The first involves simply setting the clock, letting it run for a month and comparing it to a known accurate reference (like WWV broadcasts). While that may seem crude, it allows the designer to give the end user the ability to calibrate his clock as his environment may require, even after the final product is packaged in a non-user serviceable enclosure. All the designer has to do is provide a simple utility that accesses the Calibration Byte.

The second approach is better suited to a manufacturing environment, and involves the use of some test equipment. When the Frequency Test (FT) Bit, the seventh-most significant bit in the Day Register is set to a '1,' and D7 of the Seconds Register is a '0' (Oscillator Running), DQ0 will toggle at 512 Hz during a READ of the Seconds Register. Any deviation from 512 Hz indicates the degree and direction of oscillator frequency shift at the test temperature. For example, a reading of 512.01024 Hz would indicate a +20 ppm oscillator frequency error, requiring a -10 (WR001010) to be loaded into the Calibration Byte for correction.

*Note: Setting or changing the Calibration Byte does not affect the Frequency Test output frequency.*

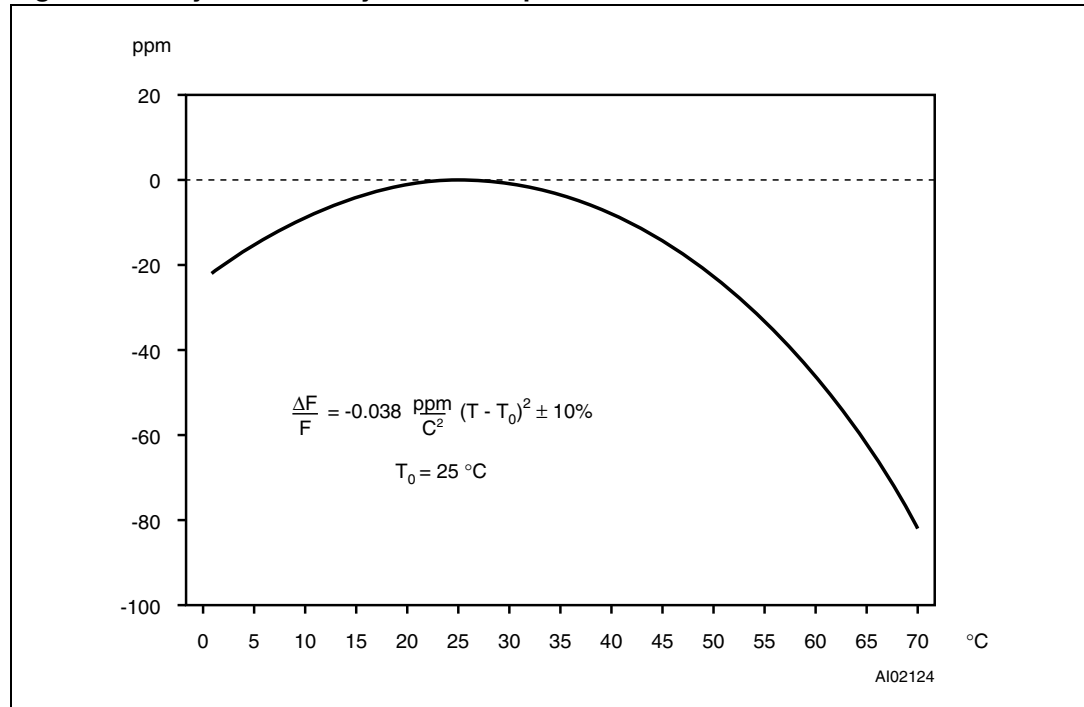
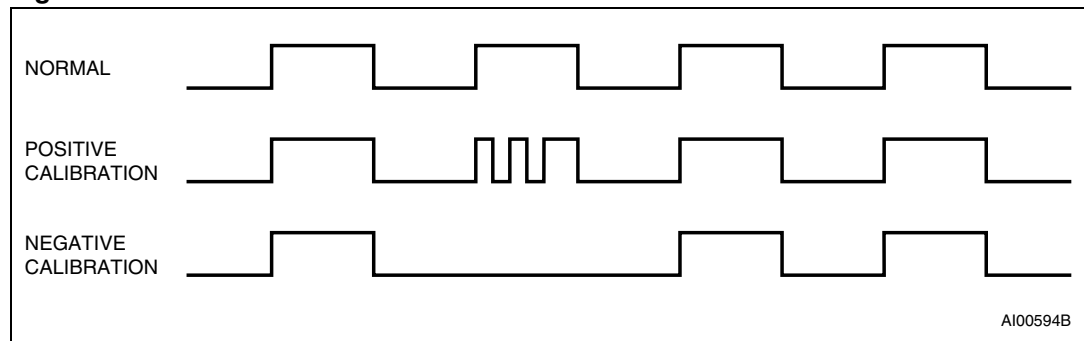
The FT Bit MUST be reset to '0' for normal clock operations to resume. The FT Bit is automatically Reset on power-down.

For more information on calibration, see Application Note AN934, "TIMEKEEPER® Calibration."

## 3.5 Century bit

Bit D5 and D4 of Clock Register 1FFCh contain the CENTURY ENABLE Bit (CEB) and the CENTURY Bit (CB). Setting CEB to a '1' will cause CB to toggle, either from a '0' to '1' or from '1' to '0' at the turn of the century (depending upon its initial state). If CEB is set to a '0,' CB will not toggle.

*Note: The WRITE Bit must be set in order to write to the CENTURY Bit.*

**Figure 8. Crystal accuracy across temperature****Figure 9. Clock calibration**

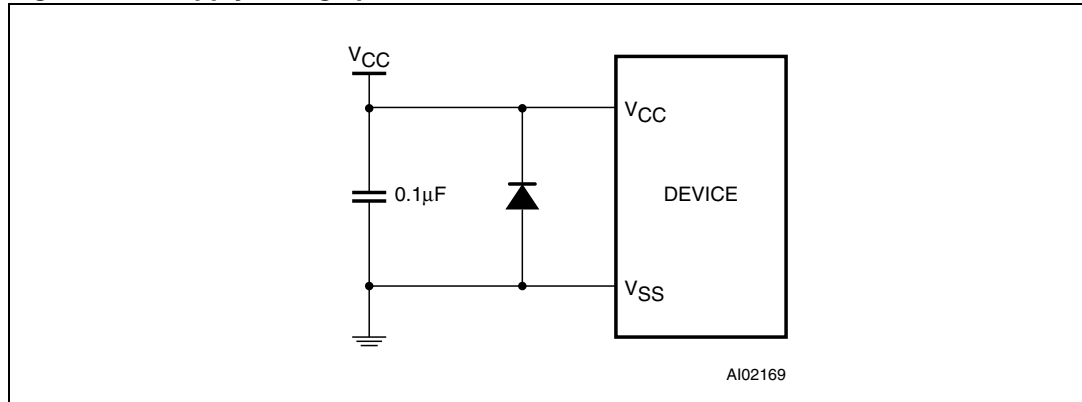
### 3.6 $V_{CC}$ noise and negative going transients

$I_{CC}$  transients, including those produced by output switching, can produce voltage fluctuations, resulting in spikes on the  $V_{CC}$  bus. These transients can be reduced if capacitors are used to store energy which stabilizes the  $V_{CC}$  bus. The energy stored in the bypass capacitors will be released as low going spikes are generated or energy will be absorbed when overshoots occur. A bypass capacitor value of  $0.1\mu\text{F}$  (as shown in [Figure 10 on page 16](#)) is recommended in order to provide the needed filtering.

In addition to transients that are caused by normal SRAM operation, power cycling can generate negative voltage spikes on  $V_{CC}$  that drive it to values below  $V_{SS}$  by as much as one volt. These negative spikes can cause data corruption in the SRAM while in battery backup mode. To protect from these voltage spikes, it is recommended to connect a schottky diode from  $V_{CC}$  to  $V_{SS}$  (cathode connected to  $V_{CC}$ , anode to  $V_{SS}$ ). Schottky diode

1N5817 is recommended for through hole and MBR5120T3 is recommended for surface mount.

**Figure 10. Supply voltage protection**





## 4 Maximum rating

Stressing the device above the rating listed in the “Absolute Maximum Ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

**Table 6. Absolute maximum ratings**

Symbol	Parameter		Value	Unit
$T_A$	Ambient Operating Temperature	Grade 1	0 to 70	°C
		Grade 6	–40 to 85	°C
$T_{STG}$	Storage Temperature ( $V_{CC}$ Off, Oscillator Off)		–40 to 85	°C
$T_{SLD}^{(1)(2)(3)}$	Lead Solder Temperature for 10 seconds		260	°C
$V_{IO}$	Input or Output Voltages	M48T35	–0.3 to 7	V
		M48T35Y	–0.3 to 7	V
$V_{CC}$	Supply Voltage	M48T35	–0.3 to 7	V
		M48T35Y	–0.3 to 7	V
$I_O$	Output Current		20	mA
$P_D$	Power Dissipation		1	W

1. For DIP package: Soldering temperature not to exceed 260°C for 10 seconds (total thermal budget not to exceed 150°C for longer than 30 seconds).
2. For SO package, standard (SnPb) lead finish: Reflow at peak temperature of 225°C (total thermal budget not to exceed 180°C for between 90 to 150 seconds).
3. For SO package, Lead-free (Pb-free) lead finish: Reflow at peak temperature of 260°C (total thermal budget not to exceed 245°C for greater than 30 seconds).

**Caution:** *Negative undershoots below –0.3V are not allowed on any pin while in the Battery Back-up mode.*

**Caution:** *Do NOT wave solder SOIC to avoid damaging SNAPHAT sockets.*

5 DC and AC parameters

This section summarizes the operating and measurement conditions, as well as the DC and AC characteristics of the device. The parameters in the following DC and AC Characteristic tables are derived from tests performed under the Measurement Conditions listed in the relevant tables. Designers should check that the operating conditions in their projects match the measurement conditions when using the quoted parameters.

Table 7. Operating and AC measurement conditions

Parameter	M48T35	M48T35Y	Unit
Supply Voltage (V <sub>CC</sub> )	4.75 to 5.5	4.5 to 5.5	V
Ambient Operating Temperature (T <sub>A</sub> )	0 to 70	−40 to 85	°C
Load Capacitance (C <sub>L</sub> )	100	100	pF
Input Rise and Fall Times	≤ 5	≤ 5	ns
Input Pulse Voltages	0 to 3	0 to 3	V
Input and Output Timing Ref. Voltages	1.5	1.5	V

Note: Output Hi-Z is defined as the point where data is no longer driven.

Figure 11. AC measurement load circuit

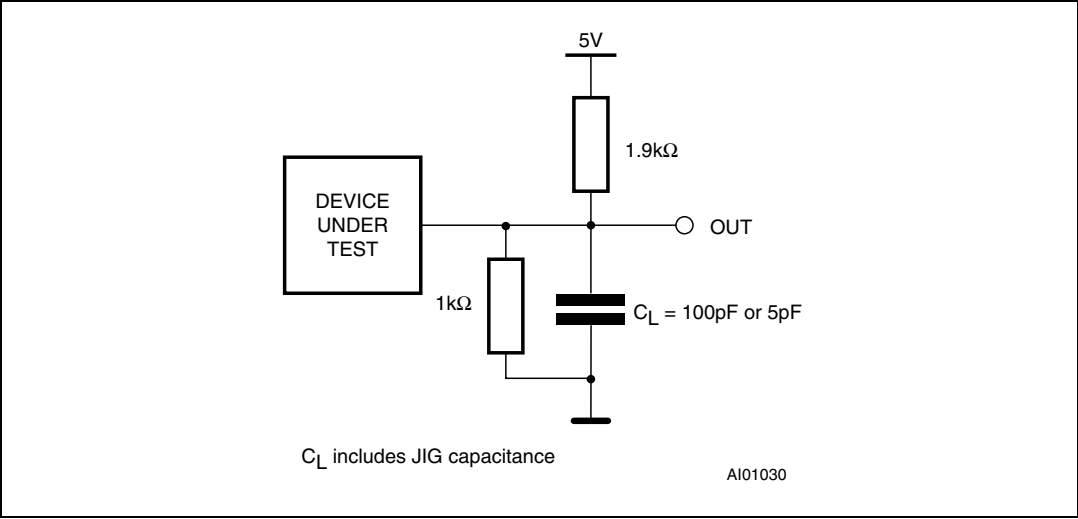


Table 8. Capacitance

Symbol	Parameter <sup>(1)(2)</sup>	Min	Max	Unit
C <sub>IN</sub>	Input Capacitance		10	pF
C <sub>OUT</sub> <sup>(3)</sup>	Output Capacitance		10	pF

- 1. Effective capacitance measured with power supply at 5V; sampled only, not 100% tested.
- 2. At 25°C, f = 1MHz.
- 3. Outputs deselected.

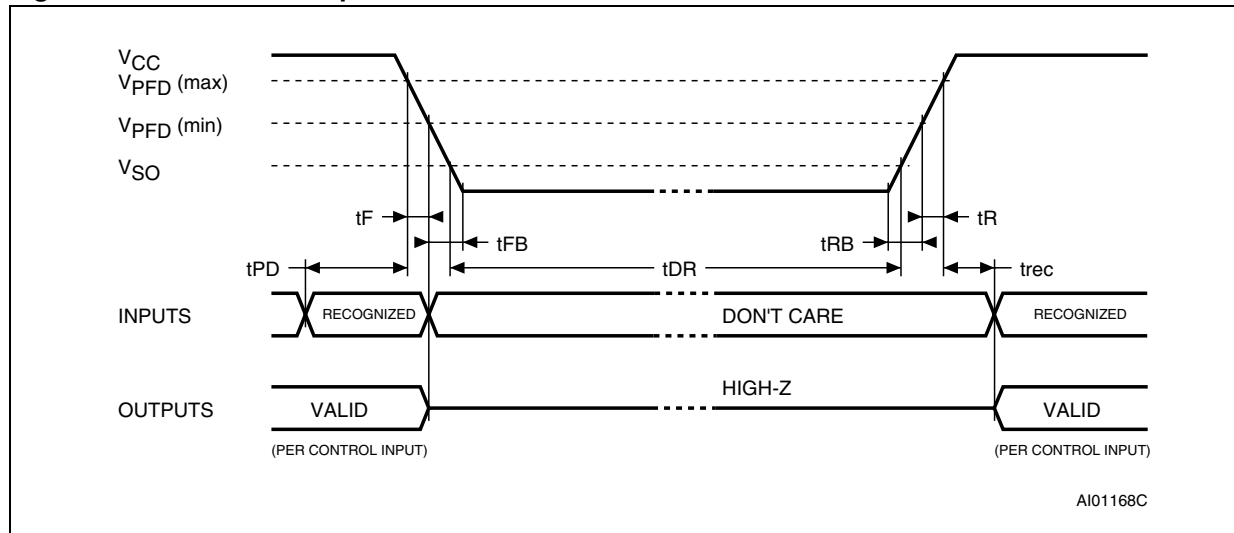
Table 9. DC characteristics

Symbol	Parameter	Test condition <sup>(1)</sup>	M48T35		M48T35Y		Unit
			Min	Max	Min	Max	
$I_{LI}$	Input Leakage Current	$0V \leq V_{IN} \leq V_{CC}$		$\pm 1$		$\pm 1$	$\mu A$
$I_{LO}^{(2)(2)}$	Output Leakage Current	$0V \leq V_{OUT} \leq V_{CC}$		$\pm 1$		$\pm 1$	$\mu A$
$I_{CC}$	Supply Current	Outputs open		50		30	mA
$I_{CC1}$	Supply Current (Standby) TTL	$\bar{E} = V_{IH}$		3		3	mA
$I_{CC2}$	Supply Current (Standby) CMOS	$\bar{E} = V_{CC} - 0.2V$		2		2	mA
$V_{IL}$	Input Low Voltage		-0.3	0.8	-0.3	0.8	V
$V_{IH}$	Input High Voltage		2.2	$V_{CC} + 0.3$	2.2	$V_{CC} + 0.3$	V
$V_{OL}$	Output Low Voltage	$I_{OL} = 2.1mA$		0.4		0.4	V
$V_{OH}$	Output High Voltage	$I_{OH} = -1mA$	2.4		2.4		V

1. Valid for Ambient Operating Temperature:  $T_A = 0$  to  $70$  or  $-40$  to  $85^\circ C$ ;  $V_{CC} = 4.75$  to  $5.5V$  or  $4.5$  to  $5.5V$  (except where noted).

2. Outputs deselected.

Figure 12. Power down/up mode AC waveforms



**Table 10. Power down/up AC characteristics**

Symbol	Parameter <sup>(1)</sup>	Min	Max	Unit
$t_{PD}$	$\overline{E}$ or $\overline{W}$ at $V_{IH}$ before Power Down	0		$\mu s$
$t_F^{(2)}$	$V_{PFD} (max)$ to $V_{PFD} (min)$ $V_{CC}$ Fall Time	300		$\mu s$
$t_{FB}^{(3)}$	$V_{PFD} (min)$ to $V_{SS}$ $V_{CC}$ Fall Time	M48T35	10	$\mu s$
		M48T35Y	10	$\mu s$
$t_R$	$V_{PFD} (min)$ to $V_{PFD} (max)$ $V_{CC}$ Rise Time	10		$\mu s$
$t_{RB}$	$V_{SS}$ to $V_{PFD} (min)$ $V_{CC}$ Rise Time	1		$\mu s$
$t_{rec}^{(4)(4)}$	$V_{PFD} (max)$ to Inputs Recognized	40	200	ms

- Valid for Ambient Operating Temperature:  $T_A = 0$  to  $70$  or  $-40$  to  $85^\circ C$ ;  $V_{CC} = 4.75$  to  $5.5V$  or  $4.5$  to  $5.5V$  (except where noted).
- $V_{PFD} (max)$  to  $V_{PFD} (min)$  fall time of less than  $t_F$  may result in deselection/write protection not occurring until  $200\mu s$  after  $V_{CC}$  passes  $V_{PFD} (min)$ .
- $V_{PFD} (min)$  to  $V_{SS}$  fall time of less than  $t_{FB}$  may cause corruption of RAM data.
- $t_{rec} (min) = 20ms$  for industrial temperature Grade 6 device.

**Table 11. Power down/up trip points DC characteristics**

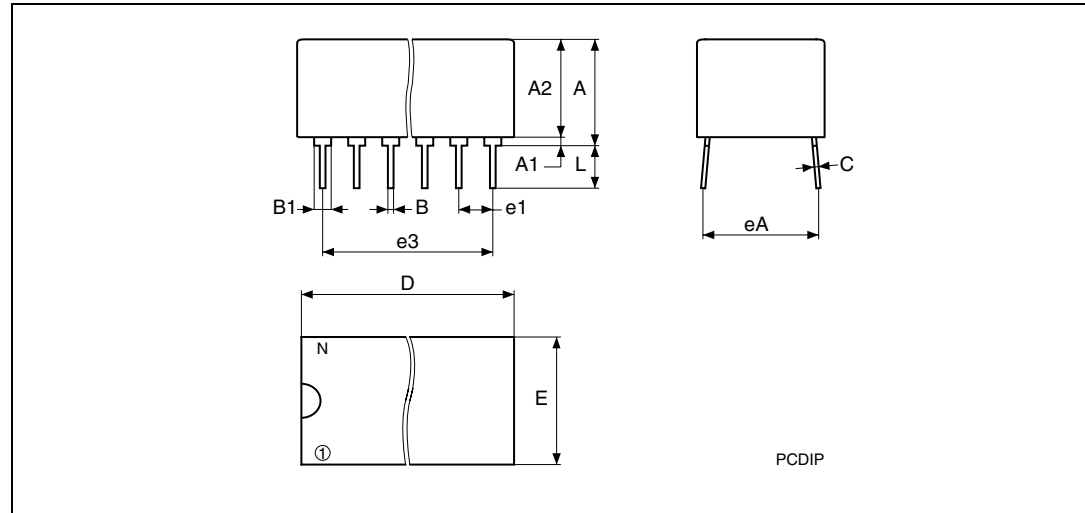
Symbol	Parameter <sup>(1)(2)</sup>		Min	Typ	Max	Unit
V <sub>PFD</sub>	Power-fail Deselect Voltage	M48T35	4.5	4.6	4.75	V
		M48T35Y	4.2	4.35	4.5	V
V <sub>SO</sub>	Battery Back-up Switchover Voltage	M48T35		3.0		V
		M48T35Y		3.0		V
t <sub>DR</sub> <sup>(3)(5)</sup>	Expected Data Retention Time	Grade 1	10 <sup>(4)</sup>			YEARS
		Grade 6	10 <sup>(5)</sup>			YEARS

- Valid for Ambient Operating Temperature:  $T_A = 0$  to  $70$  or  $-40$  to  $85^\circ C$ ;  $V_{CC} = 4.75$  to  $5.5V$  or  $4.5$  to  $5.5V$  (except where noted).
- All voltages referenced to  $V_{SS}$ .
- CAPHAT and M4T32-BR12SH1 SNAPHAT only, M4T28-BR12SH1 SNAPHAT top  $t_{DR} = 7$  years (typ).
- Using larger M4T32-BR12SH6 SNAPHAT top (recommended for Industrial Temperature Range - Grade 6 device).
- At  $25^\circ C$ ,  $V_{CC} = 0V$ .

## 6 Package mechanical information

In order to meet environmental requirements, ST offers these devices in ECOPACK<sup>®</sup> packages. These packages have a Lead-free second level interconnect. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com).

**Figure 13. PCDIP28 – 28-pin plastic DIP, battery CAPHAT, package outline**

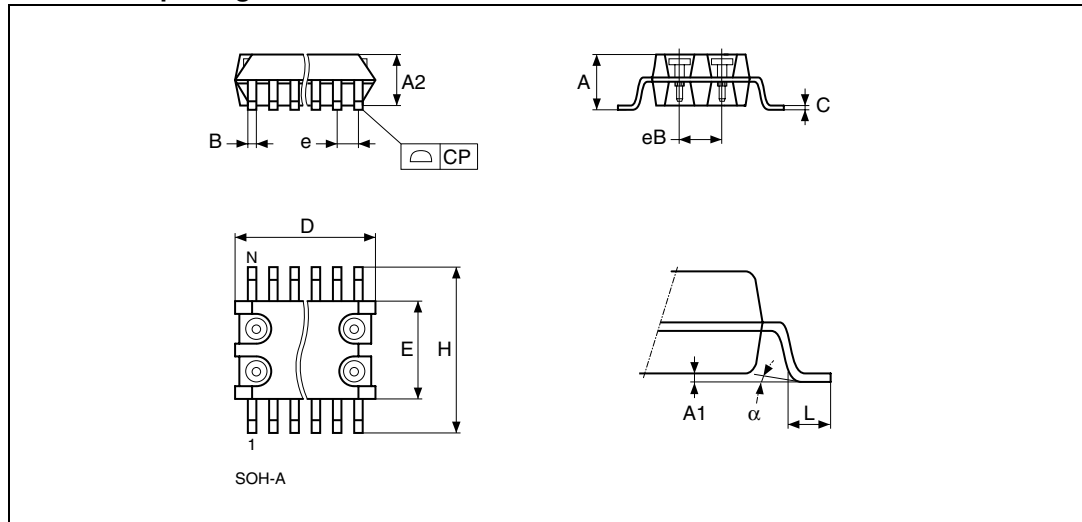


*Note: Drawing is not to scale.*

**Table 12. PCDIP28 – 28-pin plastic DIP, battery CAPHAT, package mechanical data**

Symbol	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A		8.89	9.65		0.350	0.380
A1		0.38	0.76		0.015	0.030
A2		8.38	8.89		0.330	0.350
B		0.38	0.53		0.015	0.021
B1		1.14	1.78		0.045	0.070
C		0.20	0.31		0.008	0.012
D		39.37	39.88		1.550	1.570
E		17.83	18.34		0.702	0.722
e1		2.29	2.79		0.090	0.110
e3		29.72	36.32		1.170	1.430
eA		15.24	16.00		0.600	0.630
L		3.05	3.81		0.120	0.150
N	28			28		

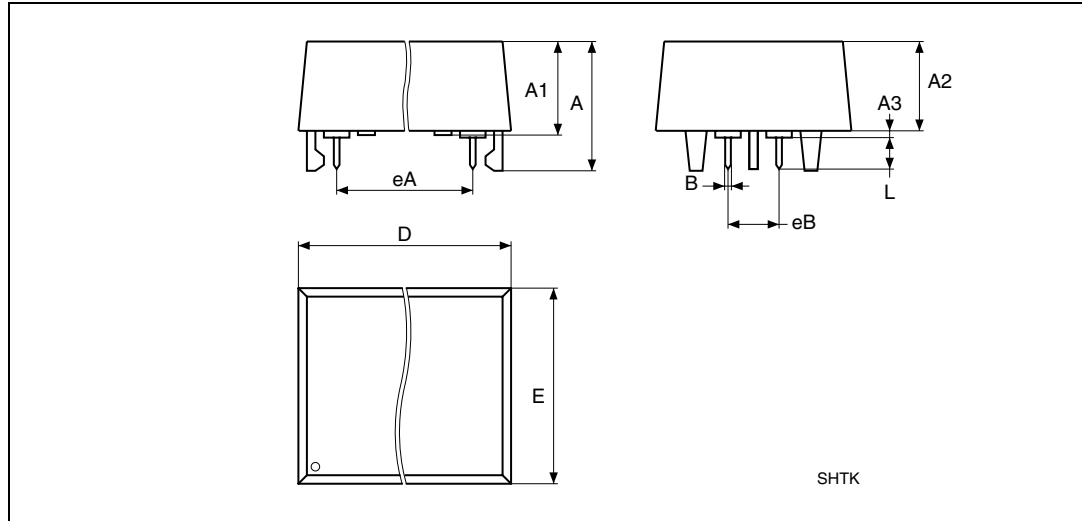
**Figure 14. SOH28 – 28-lead plastic small outline, 4-socket battery SNAPHAT, package outline**



*Note: Drawing is not to scale.*

**Table 13. SOH28 – 28-lead plastic SO, 4-socket battery SNAPHAT, package mechanical data**

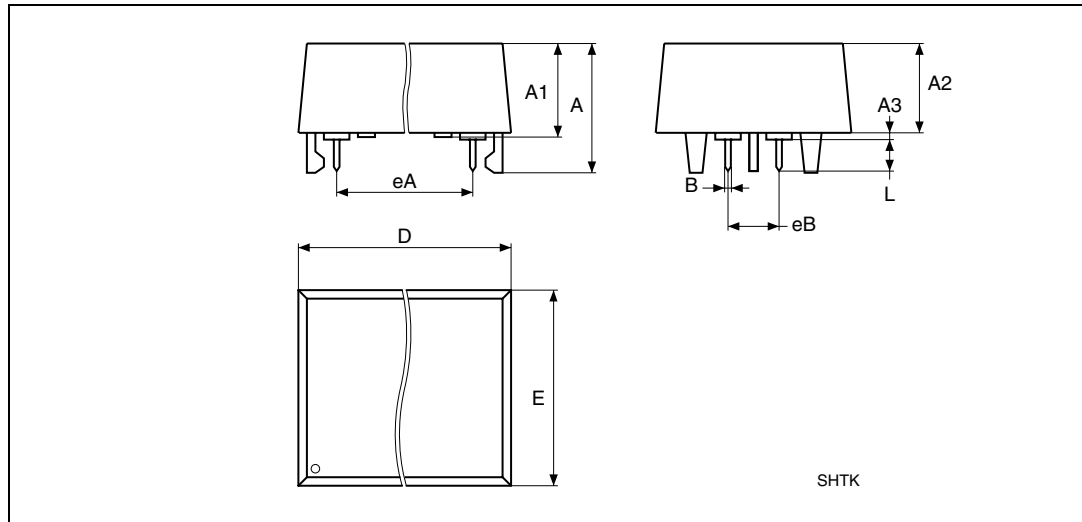
Symbol	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			3.05			0.120
A1		0.05	0.36		0.002	0.014
A2		2.34	2.69		0.092	0.106
B		0.36	0.51		0.014	0.020
C		0.15	0.32		0.006	0.012
D		17.71	18.49		0.697	0.728
E		8.23	8.89		0.324	0.350
e	1.27	–	–	0.050	–	–
eB		3.20	3.61		0.126	0.142
H		11.51	12.70		0.453	0.500
L		0.41	1.27		0.016	0.050
a		0°	8°		0°	8°
N	28			28		
CP			0.10			0.004

**Figure 15. SH – 4-pin SNAPHAT housing for 48mAh battery & crystal, package outline**

Note: Drawing is not to scale.

**Table 14. SH – 4-pin SNAPHAT housing for 48mAh battery & crystal, package mechanical data**

Symbol	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			9.78			0.385
A1		6.73	7.24		0.265	0.285
A2		6.48	6.99		0.255	0.275
A3			0.38			0.015
B		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		14.22	14.99		0.560	0.590
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090

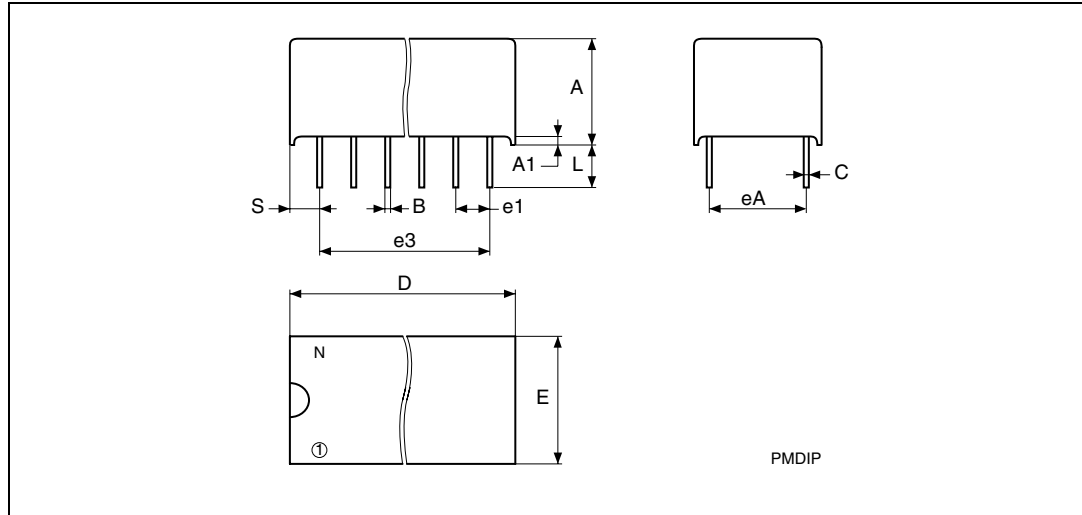
**Figure 16. SH – 4-pin SNAPHAT housing for 120mAh battery & crystal, package outline**

Note: Drawing is not to scale.

**Table 15. SH – 4-pin SNAPHAT housing for 120mAh battery & crystal, package mechanical data**

Symbol	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A			10.54			0.415
A1		8.00	8.51		0.315	0.335
A2		7.24	8.00		0.285	0.315
A3			0.38			0.015
B		0.46	0.56		0.018	0.022
D		21.21	21.84		0.835	0.860
E		17.27	18.03		0.680	0.710
eB		3.20	3.61		0.126	0.142
L		2.03	2.29		0.080	0.090



**Figure 17. PMDIP28 – 28-pin plastic DIP, hybrid, package outline**

Note: Drawing is not to scale.

**Table 16. PMDIP28 – 28-pin plastic DIP, hybrid, package mechanical data**

Symbol	mm			inches		
	Typ	Min	Max	Typ	Min	Max
A		9.27	9.53		0.365	0.375
A1		0.38			0.015	
B		0.43	0.58		0.017	0.023
C		0.20	0.33		0.008	0.013
D		37.34	37.85		1.470	1.490
E		18.03	18.80		0.710	0.740
e1		2.29	2.79		0.090	0.110
e3	33.02			1.300		
eA		14.99	16.00		0.590	0.630
L		3.05	3.81		0.120	0.150
S		1.91	2.67		0.075	0.105
N		28			28	

## 7 Part numbering

**Table 17. Ordering information scheme**

Example:	M48T	35	-70	PC	1	E
<b>Device type</b>						
M48T						
<b>Supply voltage and write protect voltage</b>						
35 <sup>(1)</sup> = $V_{CC} = 4.75$ to $5.5V$ ; $V_{PFD} = 4.5$ to $4.75V$						
35Y = $V_{CC} = 4.5$ to $5.5V$ ; $V_{PFD} = 4.2$ to $4.5V$						
<b>Speed</b>						
-70 = 70ns						
<b>Package</b>						
PC = PCDIP28						
MH <sup>(2)</sup> = SOH28						
PM = PMDIP28 (NND) <sup>(3)</sup>						
<b>Temperature range</b>						
1 = 0 to 70°C						
6 = -40 to 85°C <sup>(4)</sup>						
<b>Shipping method</b>						
<b>For SOH28:</b>						
blank = Tubes (Not for New Design - Use E)						
E = ECOPACK package, tubes						
F = ECOPACK package, tape & reel						
TR = Tape & Reel (Not for New Design - Use F)						
<b>For PCDIP28:</b>						
blank = ECOPACK package, tubes						

1. The M48T35 part is offered with the PCDIP28 (e.g., CAPHAT) package only.
2. The SOIC package (SOH28) requires the SNAPHAT<sup>®</sup> battery package which is ordered separately under the part number "M4TXX-BR12SH" in plastic tube or "M4TXX-BR12SHTR" in Tape & Reel form (see [Table 18 on page 27](#)).
3. This package is not to be used for New Design.
4. Available in SOIC package only.

**Caution:** Do not place the SNAPHAT battery package "M4TXX-BR12SH" in conductive foam as it will drain the lithium button-cell battery.

For other options, or for more information on any aspect of this device, please contact the ST sales office nearest you.

**Table 18. SNAPHAT battery table**

Part number	Description	Package
M4T28-BR12SH	Lithium Battery (48mAh) SNAPHAT	SH
M4T32-BR12SH	Lithium Battery (120mAh) SNAPHAT	SH

## 8 Revision history

**Table 19. Document revision history**

Date	Revision	Changes
Nov- 1999	1.0	First Issue
07-Feb-2000	1.1	t <sub>DR</sub> Description changed ( <a href="#">Table 9</a> )
04-Jun-2001	2.0	Reformatted; temp/voltage info. added to tables ( <a href="#">Table 8</a> , <a href="#">9</a> , <a href="#">3</a> , <a href="#">4</a> , <a href="#">10</a> , <a href="#">11</a> ); add Century Bit text
31-Jul-2001	2.1	Formatting changes based on latest document reviews
06-Mar-2002	2.2	Add PMDIP Packaging option, which is "Not for New Design" (NND) ( <a href="#">Table 17</a> , <a href="#">16</a> , and <a href="#">Figure 17</a> )
20-May-2002	2.3	Modify reflow time and temperature footnotes ( <a href="#">Table 6</a> )
26-Jun-2002	2.4	Add footnote to table ( <a href="#">Table 11</a> )
31-Mar-2003	3.0	v2.2 template applied; data retention condition updated ( <a href="#">Table 11</a> )
10-Dec-2003	4.0	Reformatted; update DC Characteristics ( <a href="#">Table 9</a> )
31-Mar-2004	5.0	Reformatted; update Pb-free package information ( <a href="#">Table 6</a> , <a href="#">17</a> )
05-Dec20-05	6.0	Updated template, Lead-free text, and remove footnote ( <a href="#">Table 9</a> , <a href="#">17</a> )
01-Aug-2007	7.0	Reformatted; added lead-free second level interconnect information to cover page and <a href="#">Section 6: Package mechanical information</a> .

**Please Read Carefully:**

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

**UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.**

**UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.**

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2007 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

[www.st.com](http://www.st.com)



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

**Телефон:** 8 (812) 309 58 32 (многоканальный)

**Факс:** 8 (812) 320-02-42

**Электронная почта:** [org@eplast1.ru](mailto:org@eplast1.ru)

**Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.